

# APPLICATION NOTE

MITSUBISHI<IGBT MODULE>

## Tentative

**CM150TL-12NF**

Pre.	M.Koura	Rev	B	H.Hanada, M.Koura
Apr.	T.Furuie 27-Nov.-'03			T.Furuie 20-May-'04

HIGH POWER SWITCHING USE

Notice : This is not a final specification. Some parametric limits are subject to change.

**CM150TL-12NF**

- $I_C$  ..... 150A
- $V_{CES}$  ..... 600V
- Insulated Type
- 6-elements in a pack

## APPLICATION

AC drive inverters & Servo controls,etc

## ABSOLUTE MAXIMUM RATINGS ( $T_j = 25^\circ\text{C}$ )

Symbol	Item	Conditions	Ratings	Units
$V_{GES}$	Collector-emitter voltage	G-E Short	600	V
$V_{GES}$	Gate-emitter voltage	C-E Short	$\pm 20$	
$I_C$	Collector current	DC, $T_c=93^\circ\text{C}$ *	150	A
$I_{CM}$		Pulse (2)	300	
$I_E$ (1)	Emitter current		150	A
$I_{EM}$ (1)		Pulse (2)	300	
$P_c$ (3)	Maximum collector dissipation	$T_c = 25^\circ\text{C}$	730	W
$T_j$	Junction temperature		-40~+150	$^\circ\text{C}$
$T_{stg}$	Storage temperature		-40~+125	
$V_{iso}$	Isolation voltage	Main terminal to base plate, AC 1 min.	2500	V
—	Torque strength	Main terminal M5	2.5~3.5	N·m
—	Torque strength	Mounting holes M5	2.5~3.5	
—	Weight	Typical value	350	g

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## ELECTRICAL CHARACTERISTICS ( $T_j = 25^\circ\text{C}$ )

Symbol	Item	Conditions	Min.	Typ.	Max.	Units
$I_{CES}$	Collector cutoff current	$V_{CE}=V_{GES}, V_{GE}=0\text{V}$	—	—	1	mA
$V_{GE(\text{th})}$	Gate-emitter threshold voltage	$I_C=15\text{mA}, V_{CE}=10\text{V}$	6	7	8	V
$I_{GES}$	Gate leakage current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}$	—	—	0.5	$\mu\text{A}$
$V_{CE(\text{sat})}$	Collector to emitter saturation voltage	$T_j = 25^\circ\text{C}$ , $I_C = 150\text{A}$	—	1.7	2.2	V
		$T_j = 125^\circ\text{C}$ , $V_{GE} = 15\text{V}$	—	1.7	—	
$C_{IES}$	Input capacitance	$V_{CE} = 10\text{V}$ $V_{GE} = 0\text{V}$	—	—	23	nF
$C_{OES}$	Output capacitance		—	—	2.8	
$C_{RES}$	Reverse transfer capacitance		—	—	0.9	
$Q_G$	Total gate charge	$V_{CC}=300\text{V}, I_C=150\text{A}, V_{GE}=15\text{V}$	—	600	—	nC
$t_{d(on)}$	Turn-on delay time	$V_{CC}=300\text{V}, I_C=150\text{A}$	—	—	120	ns
$t_r$	Turn-on rise time	$V_{GE1}=V_{GE2}=15\text{V}$	—	—	100	
$t_{d(off)}$	Turn-off delay time	$R_G=4.2\Omega$ , Inductive load	—	—	300	
$t_f$	Turn-off fall time	switching operation	—	—	300	
$t_{rr}$ ①	Reverse recovery time	$I_E=150\text{A}$	—	—	150	
$Q_{rr}$ ①	Reverse recovery charge		—	2.5	—	$\mu\text{C}$
$V_{EC}$ ①	Emitter-collector voltage	$I_E=150\text{A}, V_{GE}=0\text{V}$	—	—	2.8	V
$R_{th(j-c)Q}$	Thermal resistance	IGBT part (1/6 module) <sup>*1</sup>	—	—	0.17	$^\circ\text{C}/\text{W}$
$R_{th(j-c)R}$	Thermal resistance	FWDi part (1/6 module) <sup>*1</sup>			0.31	
$R_{th(c-f)}$	Contact thermal resistance	Case to fin, Thermal compound Applied (1/6module) <sup>*2</sup>	—	0.085	—	
$R_g$	External gate resistance		4.2	—	42	$\Omega$

\*1: Tc measured point is just under the chips.

If you use this value,  $R_{th(f-a)}$  should be measured just under the chips.

\*2: Typical value is measured by using Shin-etsu Silicone "G-746".

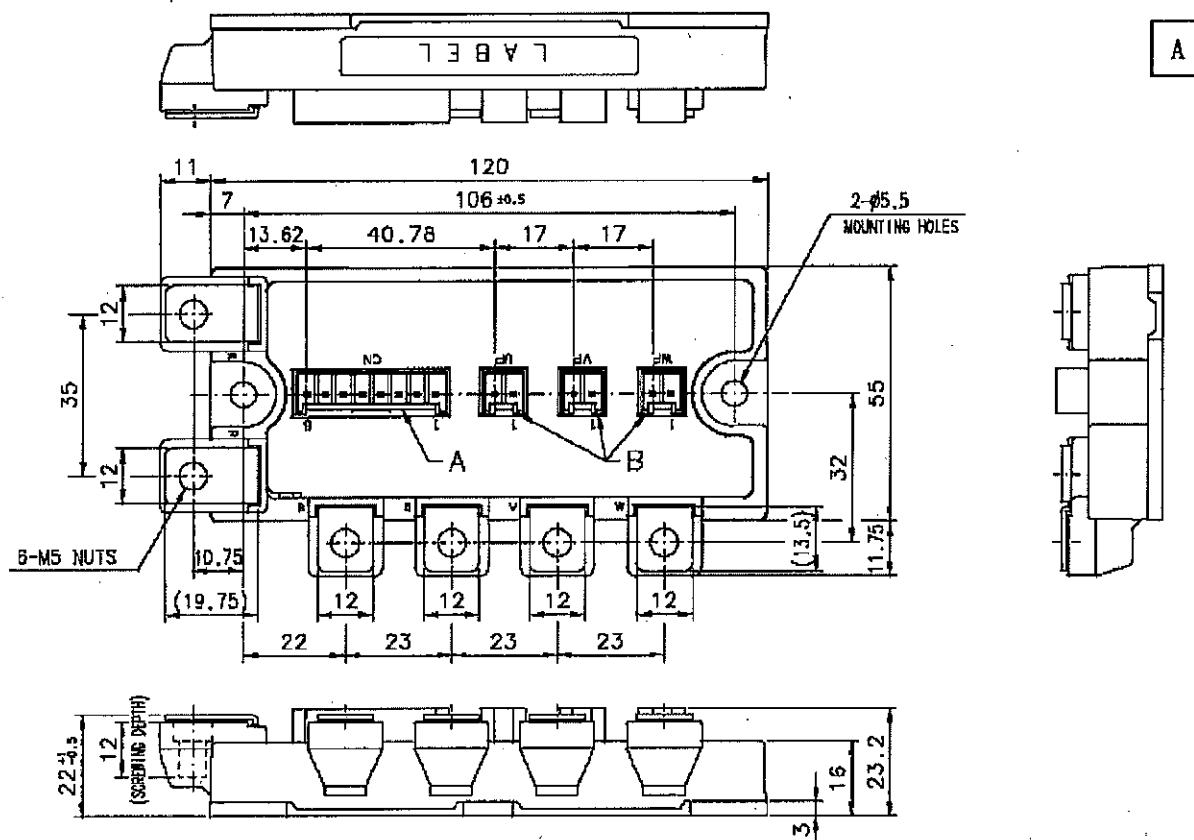
- ①  $I_E, V_{EC}, t_{rr}, Q_{rr}$  represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).
- ② Pulse width and repetition rate should be such that the device junction temp. ( $T_j$ ) dose not exceed  $T_{j\max}$  rating.
- ③ Junction temperature ( $T_j$ ) should not increase beyond  $150^\circ\text{C}$ .
- ④ Pulse width and repetition rate should be such as to cause negligible temperature rise.

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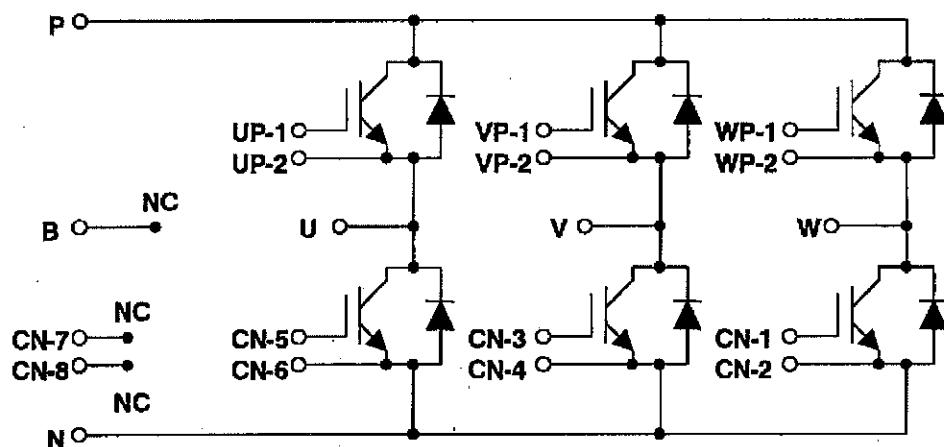
## OUTLINE DRAWING

Dimensions in mm



Housing Type of A and B  
 (J.S.T.Mfg.Co.Ltd)  
 A= B8P-VH-FB-B, B= B2P-VH-FB-B

## CIRCUIT DIAGRAM



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## CHIP LAYOUT DRAWING

Dimensions in mm

